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CDCVF2310PWR

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Datasheet of CDCVF2310PWR - IC CLK BUF 1:10 200MHZ 24TSSOP

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CDCVF2310

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CDCVF2310 2.5-V to 3.3-V High-Performance Clock Buffer

1 Features

- High-Performance 1:10 Clock Driver
- Operates up to 200 MHz at V_{DD} 3.3 V
- Pin-to-Pin Skew < 100 ps at V_{DD} 3.3 V
- V_{DD} Range: 2.3 V to 3.6 V
- Operating Temperature Range –40°C to 105°C
- Supports 105°C Ambient Temperature (see *Thermal Considerations*)
- Output Enable Glitch Suppression
- Distributes One Clock Input to Two Banks of Five Outputs
- 25-Ω On-Chip Series Damping Resistors
- Packaged in 24-Pin TSSOP

2 Applications

· General-Purpose Applications

3 Description

The CDCVF2310 device is a high-performance, lowskew clock buffer that operates up to 200 MHz. Two banks of five outputs each provide low-skew copies of CLK. After power up, the default state of the outputs is low regardless of the state of the control pins. For normal operation, the outputs of bank 1Y[0:4] or 2Y[0:4] can be placed in a low state when the control pins (1G or 2G, respectively) are held low and a negative clock edge is detected on the CLK input. The outputs of bank 1Y[0:4] or 2Y[0:4] can be switched into the buffer mode when the control pins (1G and 2G) are held high and a negative clock edge is detected on the CLK input. The device operates in a 2.5-V and 3.3-V environment. The built-in output enable glitch suppression ensures a synchronized output enable sequence to distribute full period clock signals.

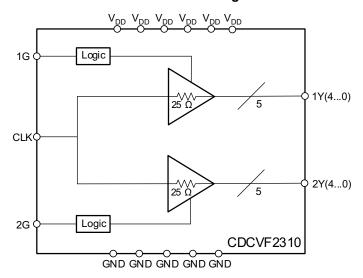
The CDCVF2310 is characterized for operation from –40°C to 85°C.

Device Information (1)

PART NUMBER	PACKAGE	BODY SIZE (NOM)		
CDCVF2310	TSSOP (24)	4.40 mm × 7.80 mm		

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Functional Block Diagram





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CDCVF2310

SCAS666D - JUNE 2001 - REVISED OCTOBER 2015

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Tab)Ie	Ωt	Cin	nte	nts

1	Features 1		8.2 Functional Block Diagram	9
2	Applications 1		8.3 Feature Description	10
3	Description 1		8.4 Device Functional Modes	11
4	Revision History2	9	Application and Implementation	12
5	Pin Configuration and Functions		9.1 Application Information	12
6	Specifications		9.2 Typical Application	12
U	6.1 Absolute Maximum Ratings	10	Power Supply Recommendations	14
	6.2 ESD Ratings	11	Layout	15
	6.3 Recommended Operating Conditions		11.1 Layout Guidelines	
	6.4 Thermal Information		11.2 Layout Example	
	6.5 Electrical Characteristics 4		11.3 Thermal Considerations	
	6.6 Timing Requirements	12	Device and Documentation Support	16
	6.7 Jitter Characteristics		12.1 Documentation Support	
	6.8 Switching Characteristics		12.2 Community Resources	
	6.9 Switching Characteristics 6		12.3 Trademarks	
	6.10 Typical Characteristics		12.4 Electrostatic Discharge Caution	16
7	Parameter Measurement Information 8		12.5 Glossary	
8	Detailed Description9	13		
	8.1 Overview			

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision C (January 2008) to Revision D

Page

Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and

Datasheet of CDCVF2310PWR - IC CLK BUF 1:10 200MHZ 24TSSOP

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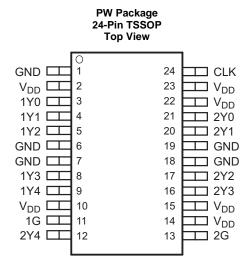


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5 Pin Configuration and Functions



Pin Functions

	PIN	1/0	DECCRIPTION
NAME	NO.	1/0	DESCRIPTION
1G	11	I	Output enable control for 1Y[0:4] outputs. This output enable is active-high, meaning the 1Y[0:4] clock outputs follow the input clock (CLK) if this pin is logic high.
2G	13	I	Output enable control for 2Y[0:4] outputs. This output enable is active-high, meaning the 2Y[0:4] clock outputs follow the input clock (CLK) if this pin is logic high.
1Y[0:4]	3, 4, 5, 8, 9	0	Buffered output clocks
2Y[0:4]	21, 20, 17, 16, 12	0	Buffered output clocks
CLK	24	1	Input reference frequency
GND	1, 6, 7, 18, 19	_	Ground
V _{DD}	2, 10, 14, 15, 22, 23	_	DC power supply, 2.3 V – 3.6 V

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{DD}	Supply voltage		-0.5	4.6	V
V _I ⁽²⁾ (3)	Input voltage		-0.5	V _{DD} + 0.5	V
Vo ^{(2) (3)}	Output voltage		-0.5	V _{DD} + 0.5	V
I _{IK}	Input clamp current	$V_I < 0$ or $V_I > V_{DD}$		±50	mA
I _{OK}	Output clamp current	$V_O < 0$ or $V_O > V_{DD}$		±50	mA
Io	Continuous total output current	$V_O = 0$ to V_{DD}		±50	mA
T _J	Maximum junction to	mperature		125	°C
T _{stg}	Storage temperature		-65	150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

⁽²⁾ The input and output negative voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

⁽³⁾ This value is limited to 4.6 V maximum.



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CDCVF2310

SCAS666D - JUNE 2001 - REVISED OCTOBER 2015

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6.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	2000	V
V(ESD)		Charged-device model (CDM), per JEDEC specification JESD22-C101 (2)	1000	V

- JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

See (1)

			MIN	NOM	MAX	UNIT
V	Cupply voltage		2.3	2.5		V
V_{DD}	Supply voltage			3.3	3.6	
V	Low lovel input veltage	V _{DD} = 3 V to 3.6 V			0.8	V
V _{IL}	Low-level input voltage	V _{DD} = 2.3 V to 2.7 V			0.7	V
V	High level input valtage	V _{DD} = 3 V to 3.6 V	2			V
V _{IH}	High-level input voltage	$V_{DD} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7			V
VI	Input voltage		0		V_{DD}	V
	Lligh lavel autout augrent	V _{DD} = 3 V to 3.6 V			12	A
I _{OH}	High-level output current	$V_{DD} = 2.3 \text{ V to } 2.7 \text{ V}$			6	mA
	Low lovel output ourrent	V _{DD} = 3 V to 3.6 V			12	A
I _{OL}	Low-level output current	V _{DD} = 2.3 V to 2.7 V	1	6	mA	
T _A	Operating free-air temperate	ıre	-40		85	°C

⁽¹⁾ Unused inputs must be held high or low to prevent them from floating.

6.4 Thermal Information

		CDCVF2310	
	THERMAL METRIC (1)	PW (TSSOP)	UNIT
		24 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	91.7	°C/W
R _{0JC(top)}	Junction-to-case (top) thermal resistance	31.2	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	46.4	°C/W
ΨЈТ	Junction-to-top characterization parameter	1.5	°C/W
ΨЈВ	Junction-to-board characterization parameter	45.8	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	n/a	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CO	MIN	TYP ⁽¹⁾	MAX	UNIT	
V_{IK}	Input voltage	$V_{DD} = 3 V$	$I_I = -18 \text{ mA}$			-1.2	V
I _I	Input current	$V_I = 0 V \text{ or } V_{DD}$	$V_{I} = 0 \text{ V or } V_{DD}$			±5	μΑ
	Static device current	$CLK = 0 \text{ V or V}_{DD}$, $I_{O} = 0 \text{ mA}$	-40°C to 85°C			80	μΑ
IDD	Static device current		≤105°C			100	μΑ
C _I	Input capacitance	V _{DD} = 2.3 V to 3.6 V	V _I = 0 V or V _{DD}		2.5		pF
Co	Output capacitance	V _{DD} = 2.3 V to 3.6 V	$V_I = 0 \text{ V or } V_{DD}$		2.8		pF

⁽¹⁾ All typical values are at respective nominal V_{DD}.

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Electrical Characteristics (continued)

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST	CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{DD} =	3.3 V ±0.3 V	1				•	
		V _{DD} = min to max	I _{OH} = -100 μA	V _{DD} - 0.2			
V_{OH}	High-level output voltage	V _{DD} = 3 V	$I_{OH} = -12 \text{ mA}$	2.1			V
		v _{DD} = 3 v	$I_{OH} = -6 \text{ mA}$	2.4			
		$V_{DD} = min to max$	$I_{OL} = -100 \mu A$			0.2	
V_{OL}	Low-level output voltage	V - 2 V	$I_{OL} = 12 \text{ mA}$			0.8	V
		$V_{DD} = 3 V$	$I_{OL} = 6 \text{ mA}$			0.55	
		$V_{DD} = 3 V$	V _O = 1 V	-28			
I_{OH}	High-level output current	$V_{DD} = 3.3 \text{ V}$	V _O = 1.65 V		-36		mA
		$V_{DD} = 3.6 \text{ V}$	V _O = 3.135 V			-14	
		$V_{DD} = 3 V$	V _O = 1.95 V	28			
I_{OL}	Low-level output current	$V_{DD} = 3.3 \text{ V}$	V _O = 1.65 V		36		mA
		$V_{DD} = 3.6 \text{ V}$	$V_0 = 0.4 \text{ V}$			14	
V _{DD} =	2.5 V ±0.2 V						
V	High-level output voltage	V_{DD} = min to max	$I_{OH} = -100 \mu A$	$V_{DD} - 0.2$			V
V _{OH}	r light-level output voltage	$V_{DD} = 2.3 \text{ V}$	$I_{OH} = -6 \text{ mA}$	1.8			V
\/	Low lovel output voltage	$V_{DD} = min to max$	I _{OL} = 100 μA			0.2	V
V_{OL}	Low-level output voltage	$V_{DD} = 2.3 \text{ V}$	$I_{OL} = 6 \text{ mA}$			0.55	V
		$V_{DD} = 2.3 \text{ V}$	$V_O = 1 V$	-17			
I_{OH}	High-level output current	V _{DD} = 2.5 V	V _O = 1.25 V		-25		mA
		V _{DD} = 2.7 V	V _O = 2.375 V			-10	
		V _{DD} = 2.3 V	V _O = 1.2 V	17			
I_{OL}	Low-level output current	V _{DD} = 2.5 V	V _O = 1.25 V		25		mA
		V _{DD} = 2.7 V	V _O = 0.3 V			10	

6.6 Timing Requirements

over recommended ranges of supply voltage and operating free-air temperature

0.0	000	or suppry remage and specialing need an temperature			
			MIN	MAX	UNIT
	Clask fraguency	V _{DD} = 3 V to 3.6 V	0	200	MI I-
t _{clk}	Clock frequency	V _{DD} = 2.3 V to 2.7 V	0	170	MHz

6.7 Jitter Characteristics

Characterized using CDCVF2310 Performance EVM when V_{DD} = 3.3 V. Outputs not under test are terminated to 50 Ω .

	1		
PARAMETER	TEST CONDITIONS	TYP	UNIT
Additive phase litter from input to cutout 1/0	12 kHz to 5 MHz, f _{out} = 30.72 MHz	52	fo
t _{jitter} Additive phase jitter from input to output 1Y0	12 kHz to 20 MHz, f _{out} = 125 MHz	45	fs rms



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6.8 Switching Characteristics

V_{DD}= 3.3V ±0.3V (see Figure 2) and over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT
t _{PLH}	CLK to Yn	f = 0 MHz to 200 MHz For circuit load, see Figure 2.	1.3	2.8	ns
t _{sk(o)}	Output skew (Ym to Yn) (1) (see Figure 4)			100	ps
t _{sk(p)}	Pulse skew (see Figure 5)			250	ps
t _{sk(pp)}	Part-to-part skew			500	ps
t _r	Rise time (see Figure 3)	V _O = 0.4 V to 2 V	0.7	2	V/ns
t _f	Fall time (see Figure 3)	V _O = 2 V to 0.4 V	0.7	2	V/ns
t _{su(en)}	Enable setup time, G_high before CLK ↓		0.1		ns
t _{su(dis)}	Disable setup time, G_low before CLK ↓		0.1		ns
t _{h(en)}	Enable hold time, G_high after CLK ↓		0.4		ns
t _{h(dis)}	Disable hold time, G_low after CLK ↓		0.4		ns

⁽¹⁾ The $t_{sk(o)}$ specification is only valid for equal loading of all outputs.

6.9 Switching Characteristics

V_{DD}= 2.5V ±0.2V (see Figure 2) and over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT	
t _{PLH}	CLK to Yn	f = 0 MHz to 170 MHz For circuit load, see Figure 2.	1.5	3.5	ns	
t _{sk(o)}	Output skew (Ym to Yn) (1) (see Figure 4)			170	ps	
t _{sk(p)}	Pulse skew (see Figure 5)			400	ps	
t _{sk(pp)}	Part-to-part skew			600	ps	
t _r	Rise time (see Figure 3)	$V_0 = 0.4 \text{ V to } 1.7 \text{ V}$	0.5	1.4	V/ns	
t _f	Fall time (see Figure 3)	V _O = 1.7 V to 0.4 V	0.5	1.4	V/ns	
t _{su(en)}	Enable setup time, G_high before CLK ↓		0.1		ns	
t _{su(dis)}	Disable setup time, G_low before CLK ↓		0.1		ns	
t _{h(en)}	Enable hold time, G_high after CLK ↓		0.4		ns	
t _{h(dis)}	Disable hold time, G_low after CLK ↓		0.4		ns	

⁽¹⁾ The $t_{sk(o)}$ specification is only valid for equal loading of all outputs.

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6.10 Typical Characteristics

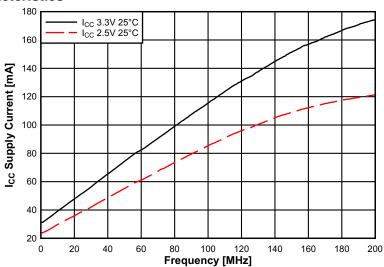


Figure 1. Supply Current vs Frequency

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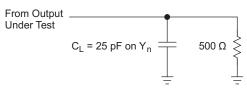


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7 Parameter Measurement Information



- A. C_L includes probe and jig capacitance.
- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 200 MHz, $Z_O = 50 \Omega$, $t_r < 1.2 \text{ ns}$, $t_f < 1.2 \text{ ns}$.

Figure 2. Test Load Circuit

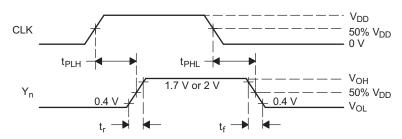


Figure 3. Voltage Waveforms Propagation Delay Times

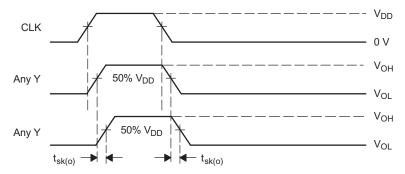
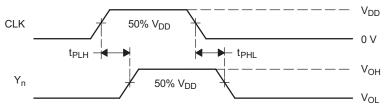


Figure 4. Output Skew



NOTE: $t_{sk(p)} = |t_{PLH} - t_{PHL}|$

Figure 5. Pulse Skew

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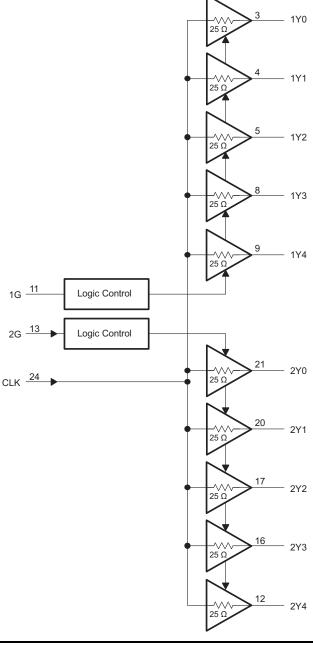
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Detailed Description

8.1 Overview

The CDCVF2310 is a high-performance, low-skew clock buffer that operates up to 200 MHz. Two banks of five outputs each provide low-skew copies of CLK. After power up, the default state of the outputs is low regardless of the state of the control pins. For normal operation, the outputs of bank 1Y[0:4] or 2Y[0:4] can be placed in a low state when the control pins (1G or 2G, respectively) are held low and a negative clock edge is detected on the CLK input. The outputs of bank 1Y[0:4] or 2Y[0:4] can be switched into the buffer mode when the control pins (1G and 2G) are held high and a negative clock edge is detected on the CLK input. The device operates in a 2.5-V and 3.3-V environment. The built-in output enable glitch suppression ensures a synchronized output enable sequence to distribute full period clock signals.

8.2 Functional Block Diagram





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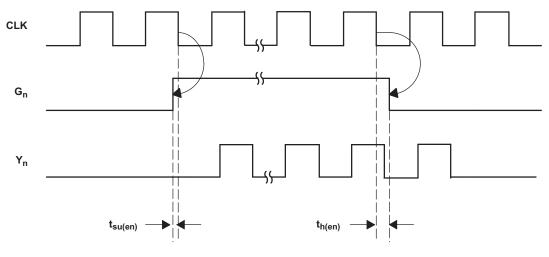
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8.3 Feature Description

8.3.1 Output Enable Glitch Suppression Circuit

The purpose of the glitch suppression circuitry is to ensure the output enable sequence is synchronized with the clock input such that the output buffer is enabled or disabled on the next full period of the input clock (negative edge triggered by the input clock) (see Figure 6).

The G input must fulfill the timing requirements (t_{su}, t_h) according to the *Switching Characteristics* table for predictable operation.



a) Enable Mode

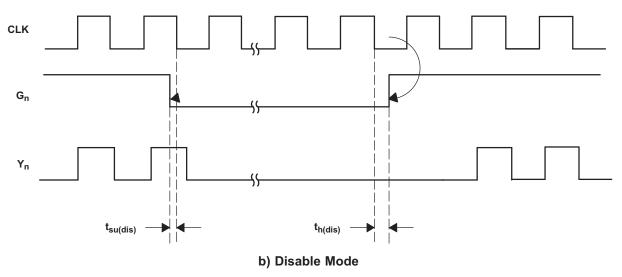


Figure 6. Enable and Disable Mode Relative to CLK

Product Folder Links: CDCVF2310

10

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8.4 Device Functional Modes

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Table 1 lists the functional modes for the CDCVF2310.

Table 1. Function Table

	INPUT		OUTPUT			
1G	2G	CLK	1Y[0:4]	2Y[0:4]		
L	L	↓	L	L		
Н	L	↓	CLK ⁽¹⁾	L		
L	Н	↓	L	CLK ⁽¹⁾		
Н	Н	↓	CLK ⁽¹⁾	CLK ⁽¹⁾		

(1) After detecting one negative edge on the CLK input, the output follows the input CLK if the control pin is held high.

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9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The CDCVF2310 is a LVCMOS buffer solution that can operate up to 200 MHz. Low output skew as well as the ability for glitchless output enable and disable is featured to simultaneously enable or disable buffered clock outputs as necessary in the application.

9.2 Typical Application

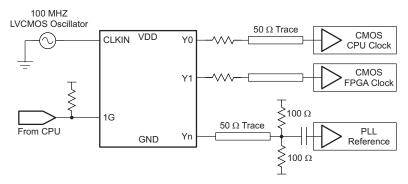


Figure 7. Example System Configuration

9.2.1 Design Requirements

The CDCVF2310 shown in Figure 7 is configured to fan out a 100-MHz signal from a local LVCMOS oscillator. The CPU is configured to control the output state through 1G.

The configuration example is driving three LVCMOS receivers in a backplane application with the following properties:

- The CPU clock can accept a full swing DC-coupled LVCMOS signal. A series resistor is placed near the CDCVF2310 to closely match the characteristic impedance of the trace to minimize reflections.
- The FPGA clock is similarly DC-coupled with an appropriate series resistor placed near the CDCVF2310.
- The PLL in this example can accept a lower amplitude signal, so a Thevenin's equivalent termination is used. The PLL receiver features internal biasing, so AC-coupling can be used when common-mode voltage is mismatched.

9.2.2 Detailed Design Procedure

Refer to *Electrical Characteristics* table to determine the appropriate series resistance needed for matching the output impedance of the CDCVF2310 to that of the characteristic impedance of the transmission line.

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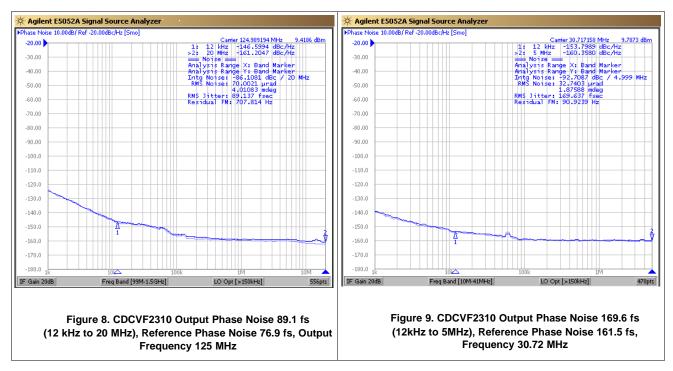
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Typical Application (continued)

9.2.3 Application Curves



The low-additive jitter of the CDCVF2310 can be seen in the previous application plots. The low-noise, 125-MHz input source drives the CDCVF2310, resulting in 45-fs RMS additive jitter when integrated from 12 kHz to 20 MHz for this configuration. The low-noise 30.72-MHz input source drives the CDCVF2310, resulting in 52-fs RMS additive jitter when integrated from 12 kHz to 5 MHz for this configuration.

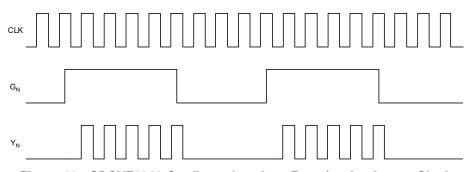


Figure 10. CDCVF2310 Configured as Gate Function for Output Clock

The CDCVF2310 can be configured to generate a gated clock using the G_N Please refer to *Output Enable Glitch Suppression Circuit* for required timings.

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10 Power Supply Recommendations

High-performance clock buffers are sensitive to noise on the power supply, which can dramatically increase the additive jitter of the buffer. Thus, it is essential to reduce noise from the system power supply, especially when jitter or phase noise is critical to applications.

Filter capacitors are used to eliminate the low-frequency noise from the power supply, where the bypass capacitors provide the very low impedance path for high-frequency noise and guards the power supply system against induced fluctuations. These bypass capacitors also provide instantaneous current surges as required by the device and should have low equivalent series resistance (ESR). To properly use the bypass capacitors, they must be placed very close to the power-supply terminals and laid out with short loops to minimize inductance. TI recommends adding as many high-frequency (for example, 0.1 μ F) bypass capacitors, as there are supply terminals in the package. TI recommends, but does not require, inserting a ferrite bead between the board power supply and the chip power supply that isolates the high-frequency switching noises generated by the clock buffer; these beads prevent the switching noise from leaking into the board supply. It is imperative to choose an appropriate ferrite bead with very low DC resistance to provide adequate isolation between the board supply and the chip supply, as well as to maintain a voltage at the supply terminals that is greater than the minimum voltage required for proper operation.

Figure 12 shows this recommended power supply decoupling method.

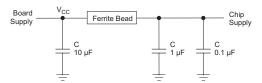


Figure 11. Power Supply Decoupling

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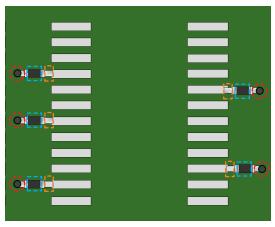
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11 Layout

11.1 Layout Guidelines

Figure 12 shows a conceptual layout detailing recommended placement of power supply bypass capacitors. For component side mounting, use 0402 body size capacitors to facilitate signal routing. Keep the connections between the bypass capacitors and the power supply on the device as short as possible. Ground the other side of the capacitor using a low-impedance connection to the ground plane.

11.2 Layout Example



- Ground bypass capacitor with low impedance connection to ground plane
- 0402 or smaller body size capacitors are recommended
- Place bypass power supply capacitors as short as possible to device pin

Figure 12. PCB Conceptual Layout

11.3 Thermal Considerations

CDCVF2310 supports high ambient temperature up to 105°C. The system designer needs to ensure that the maximum junction temperature is not exceeded. Following Equation 1 can be used to calculate the junction temperature based on the measured case temperature. The case temperature is defined as the hottest temperature on the top of the device. The case temperature measurement can be performed with (in order of accuracy) an IR camera, a fluor-optic probe, a thermocouple, or IR gun with a maximum field view of 4-mm diameter just to name a few techniques. Further information can be found at SPRA953 and SLUA566

 $T_{\text{junction}} = T_{\text{case}} + (\psi_{\text{ti}} \times \text{Power}) \tag{1}$



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12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation, see the following:

Using Thermal Calculation Tools for Analog Components, SLUA566

12.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

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Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.3 Trademarks

E2E is a trademark of Texas Instruments.
All other trademarks are the property of their respective owners.

12.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.5 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



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PACKAGE OPTION ADDENDUM

16-Jul-2015

PACKAGING INFORMATION

Orderable Device	Status	Package Type		Pins	-	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CDCVF2310PW	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CKV2310	Samples
CDCVF2310PWG4	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CKV2310	Samples
CDCVF2310PWR	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CKV2310	Samples
CDCVF2310PWRG4	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	CKV2310	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but Tl does not recommend using this part in a new design. PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: Tl has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): Tl's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "--" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

Addendum-Page 1



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PACKAGE OPTION ADDENDUM

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OTHER QUALIFIED VERSIONS OF CDCVF2310:

• Enhanced Product: CDCVF2310-EP

NOTE: Qualified Version Definitions:

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

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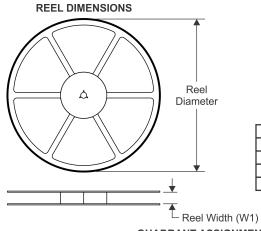
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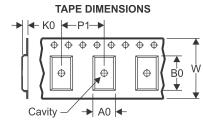


PACKAGE MATERIALS INFORMATION

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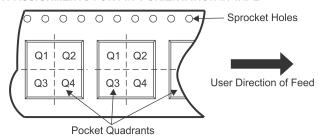
TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDCVF2310PWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1



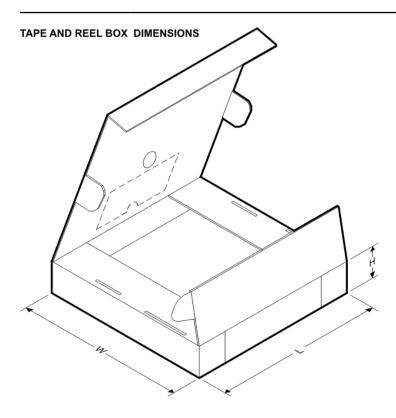
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*All dimensions are nominal

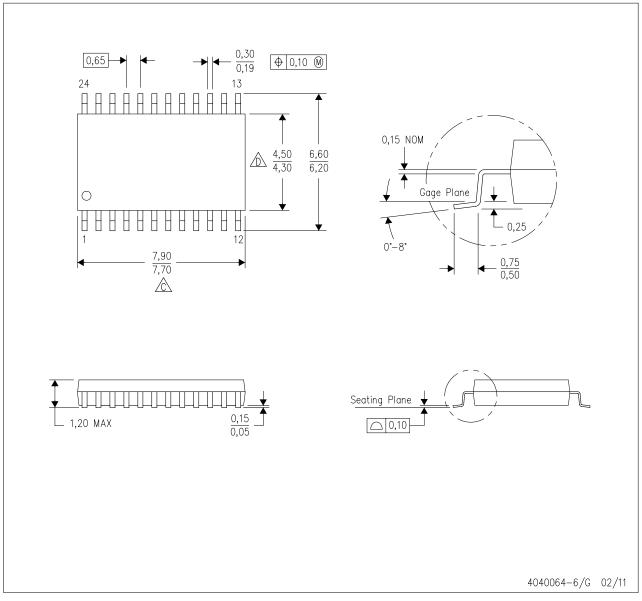
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CDCVF2310PWR	TSSOP	PW	24	2000	367.0	367.0	38.0



MECHANICAL DATA

PW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



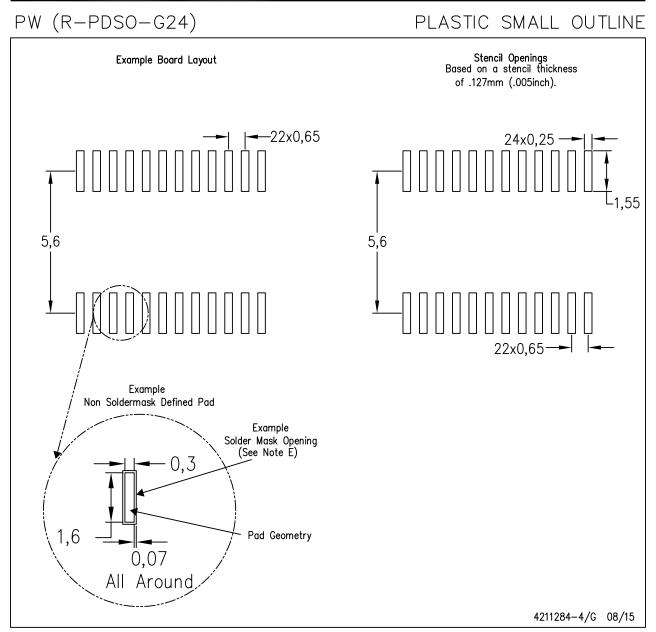
NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153





LAND PATTERN DATA



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





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